

TECHNICAL REPORT

INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

Specification for radio disturbance and immunity measuring apparatus and methods -

Part 4-4: The CISPR model for the calculation of limits for the protection of radio services

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CONTENTS

FOREWORD	4
1 Scope	6
2 Normative references	6
3 Terms and definitions	6
4 The CISPR model for the calculation of limits	7
4.1 General	7
4.2 Basic disturbance coupling mechanisms	8
4.2.1 Coupling scenarios	8
4.2.2 Description of coupling paths	8
4.3 Condition at the victim receiver	9
4.4 Systematic factors	9
4.4.1 General	9
4.4.2 Factors conditional on the path between source and victim	10
4.4.3 Factors conditional on standardised test	10
4.5 Probabilistic factors	11
4.5.1 General	11
4.5.2 S_{TX} probabilistic factor representing the effect of events that the major lobe of the radiation is in the direction of the victim receiver	12
4.5.3 S_{RX} probabilistic factor representing the effect of directional receiving aerials having maximum pick-up in the direction of the disturbing source	12
4.5.4 S_{stat} probabilistic factor representing the effect of events that the victim receiver is stationary	12
4.5.5 S_{freq} probabilistic factor representing the effect of equipment generating a disturbing signal on a critical frequency at which the radio receiver is susceptible	13
4.5.6 S_{mi} probabilistic factor representing the effect of events that the disturbing signal is below $E_{ir,corr}$	13
4.5.7 S_{wf} probabilistic factor representing the effect of events that the type of disturbing signal being generated will produce a significant effect in the receiving system	14
4.5.8 S_{time} probabilistic factor representing the effect of coincident operation of the disturbing source and the receiving system	14
4.5.9 S_{loc} probabilistic factor representing the effect of the disturbing source being within the distance at which interference is likely to occur	15
4.5.10 S_{att} Probabilistic factor representing the effect of events that obstacles (including buildings) provide attenuation	16
4.6 Specification of a technical CISPR limit	16
4.6.1 General	16
4.6.2 Determination of the permissible interference field strength values	17
4.6.3 Application of the systematic factors	18
4.6.4 Application of the probabilistic factors	18
4.6.5 Determination of a technical CISPR limit	22
4.7 Documentation of the result	23
Annex A (informative) Basic mathematical background	24
A.1 General	24
A.1.1 Overview	24
A.1.2 Generation of EM disturbances	24

A.1.3	Immunity from EM disturbances.....	24
A.1.4	Planning a radio service	24
A.2	Probability of interference.....	25
A.2.1	General.....	25
A.2.2	Derivation of probability of interference	25
A.3	A mathematical basis for the calculation of CISPR limits.....	27
A.3.1	General.....	27
A.3.2	Generation of EM disturbances (source of disturbance)	27
A.3.3	Immunity from EM disturbances (victim receiver).....	29
Annex B (informative) Mathematical basis for the calculation of the probability distribution of the maximum disturbance amplitude at a receiver when surrounded by uniformly distributed sources		30
B.1	General	30
B.2	Model and assumptions.....	30
B.3	Probability distribution of received amplitude of a disturbance from an arbitrary source	31
B.4	Probability distribution of the maximum disturbance amplitude	34
B.5	Comparison to Monte Carlo simulation results	38
B.6	Application to some specific distributions	39
B.6.1	General.....	39
B.6.2	Binary discrete distribution.....	39
B.6.3	Lognormal distribution	40
B.6.4	Exponential distribution	41
Annex C (informative) A simple approximation of the mean value and standard deviation of the probabilistic factor of location coincidence		44
Annex D (informative) Wire-line coupling.....		46
D.1	Mains coupling using the mains decoupling factor.....	46
D.2	Mains and telecommunication line coupling by radiation from a network	47
D.2.1	General.....	47
D.2.2	Example for the AM frequency range	50
D.2.3	Guidance for field-strength measurements.....	51
D.2.4	Example of a measurement result.....	51
Annex E (informative) Cross reference for probabilistic factors.....		55
Bibliography.....		57
Figure 1 – Basic RFI model for source without radio module		8
Figure 2 – Basic RFI model for source with radio module.....		8
Figure 3 – $t\alpha$ against confidence level α		20
Figure B.1 – Geometry of the interference model		31
Figure B.2 – Integration ranges for conducting the integral (see Equation (B.8))		33
Figure B.3 – Probability densities of the maximum received disturbance amplitude		39
Figure C.1 – Comparison of the exact and approximated values in the case of $x = 1$		45
Figure D.1 – Example of conversion factors – field strength/common-mode voltage (in dB) – at feed point, found in practice		51
Figure D.2 – Example of conversion factors – field strength generated by differential-mode voltage – at feed point, found in practice.....		52

Figure D.3 – Example of conversion factors – field strength generated by differential-mode voltage –outside buildings and electrical substations, found in practice	53
Figure D.4 – Example of conversion factors – field strength generated by differential-mode voltage – inside buildings, found in practice.....	54
Table 1 – Coupling scenarios and relevant systematic/probabilistic factors.....	17
Table E.1 – Cross reference of probabilistic factors in this document and CISPR TR 16-4-4:2007, CISPR TR 16-4-4:2007/AMD1:2017 and CISPR TR 16-4-4:2007/AMD2:2020	55

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Specification for radio disturbance and immunity measuring apparatus and methods - Part 4-4: The CISPR model for the calculation of limits for the protection of radio services

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CISPR TR 16-4-4 has been prepared by subcommittee H: Limits for the protection of radio services, of IEC technical committee CISPR. It is a Technical report.

This third edition cancels and replaces the second edition published in 2007, Amendment 1:2017 and Amendment 2:2020. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) full revision of the limit calculation model;
- b) the content on statistics of complaints was taken from this publication and published as separate document (CISPR TR 16-4-6);

- c) application cases/rationales were separated from the model and will be handled in another document to be drafted.

The text of this Technical Report is based on the following documents:

Draft	Report on voting
CIS/H/524/DTR	CIS/H/536A/RVDTR

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this Technical Report is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at <http://www.iec.ch/standardsdev/publications>.

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